BGR420

NPN Silicon RF Transistor With Bias Circuitry

Small Signal Discretes



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BGR420, NPN Silicon RF Transistor With Bias Circuitry					
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NPN Silicon RF Transistor With Bias Circuitry*

NPN Silicon RF Transistor With Bias Circuitry* 1

Features

- Noise figure NF = 1.5 dB at 0.4 GHz
- Gain S_{21} = 26 dB at 0.4 GHz
- On chip bias circuitry, 13 mA bias current at $V_{\rm CC}$ = 3.6 V; $V_{\rm BB}$ = 2.8 V
- SIEGET ® 25 GHz f_T -Line
- Pb-free (RoHS compliant) package
- * Short term description



Applications

LNAs

2 **Description**

The BGR420 is a monolithic silicon amplifier with a NPN silicon RF transistor and integrated resistors for biasing.

Туре	Package	Marking
BGR420	SOT343	AWs

Note: ESD (Electrostatic discharge) sensitive device, observe handling precaution!

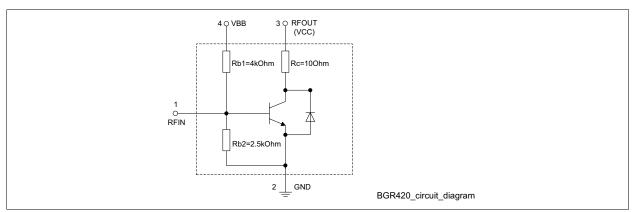


Figure 1 Circuit diagram

Note: Due to design there is an additional diode between emitter and collector, which does not affect normal operation for common emitter configuration.



Description

Table 1 Pinning table

Pin	Function
1	RFIN
2	GND
3	RFOUT (VCC)
4	VBB

2.1 Maximum Ratings

Note: All Voltages refer to GND-node

Table 2 Maximum ratings

Parameter	Symbol	Value	Unit
Current at pin VCC	$I_{\sf CC}$	25	mA
Voltage at pin VCC	$V_{\sf CC}$	13	V
Current at pin VBB	I_{BB}	2.2	mA
Voltage at pin VBB	V_{BB}	8	V
Current at pin RFIN	I_{IN}	3	mA
Voltage at pin RFIN	V_{IN}	5	V
Total power dissipation ¹⁾ $T_{\rm S}$ = 115 °C	P _{tot}	120	mW
Operation junction temperature range	T_{jo}	-65 150	°C
Storage junction temperature range	$T_{ m jstg}$	-65 150	°C

¹⁾ $T_{\rm S}$ is measured on the emitter (GND) lead at the soldering point to the pcb

Note: Stresses above the max. values listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions even only for a short moment may affect device reliability. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the integrated circuit. Absolute maximum ratings typically differ heavily from recommended operation conditions

2.2 Thermal Resistance

Table 3 Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾	R_{thJS}	≤ 290	K/W

¹⁾ For calculation of $R_{\rm thJA}$ please refer to Application Note Thermal Resistance.

Electrical Characteristics

3 Electrical Characteristics

Table 4 DC characteristics at T_A = 25 °C, unless otherwise specified

Parameter	Symbol	Values			Unit	Note /
		Min.	Тур.	Max.		Test Condition
VCC-GND cutoff current	$I_{\rm CC}$			10	μΑ	$V_{\rm CC}$ = 13 V, $I_{\rm BB}$ = 0, $V_{\rm IN}$ = 0
Current at pin VCC	$I_{\rm CC}$	7	13	20	mA	$V_{\rm BB}$ = 2.8 V, $I_{\rm IN}$ = 0, $V_{\rm CC}$ = 3.6 V

Table 5 AC characteristics (measured in test circuit Figure 2; verified by random sampling) $T_{\rm A}$ = 25 °C, $V_{\rm BB}$ = 2.8 V, $V_{\rm CC}$ = 3.6 V, $Z_{\rm 0}$ = 50 Ω , unless otherwise specified

Parameter	Symbol	Values			Unit	Note /
		Min.	Тур.	Max.		Test Condition
Insertion power gain	S ₂₁		26.0		dB	f = 0.4 GHz
			15.5			f = 1.8 GHz
Reverse isolation	S_{12}		-32.5		dB	f = 0.4 GHz
			-23.4			f = 1.8 GHz
Noise figure, $Z_{S} = Z_{Sopt}$	NF		1.5		dB	f = 0.4 GHz
·			1.7			f = 1.8 GHz
Third order intercept point at the	OIP_3		21		dBm	f = 0.4 GHz
output ¹⁾			23			f = 1.8 GHz
1 dB compression point at the output	OP_{-1dB}		5.5		dBm	f = 0.4 GHz
			7.4			f = 1.8 GHz
Return loss input	S ₁₁		-7.3		dB	f = 0.4 GHz
			-11			f = 1.8 GHz
Return loss output	S_{22}		-2.5		dB	f = 0.4 GHz
			-9.5			f = 1.8 GHz

¹⁾ OIP_3 value depends on termination of all intermodulation frequency components. Termination used for this measurement is 50 Ω from 0.1 MHz to 6 GHz.

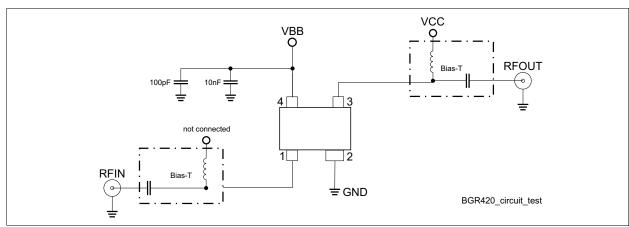


Figure 2 BGR420 test circuit



Package Information

4 Package Information

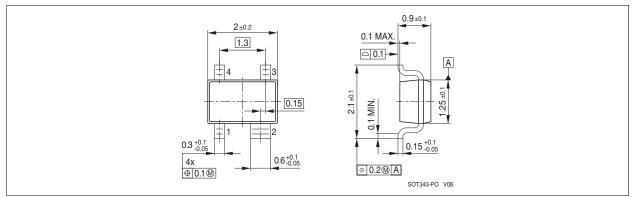


Figure 3 Package Outline SOT343

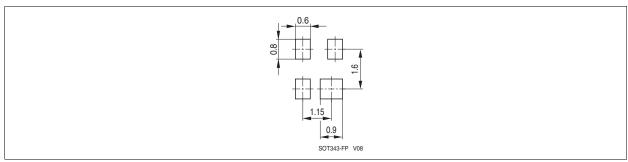


Figure 4 Footprint of SOT343

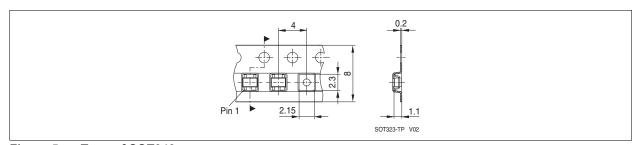


Figure 5 Tape of SOT343